,	Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
09/892,622	MIYAWAKI ET AL.
Examiner	Art Unit
Cong-Lac Huynh	2178

	SEAR	CHED	
Class	Subclass	Date	Examiner
715	500	7/27/2007	CLH
	501.1	7/27/2007	CLH
	530	7/27/2007	CLH
	531	7/27/2007	CLH
	764	7/27/2007	CLH
	769	7/27/2007	CLH

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARCI	OTES H STRATEGY)
	DATE	EXMR
East	7/27/2007	CLH
IEEE	7/27/2007	CLH
Google	7/27/2007	CLH